### **Power MOSFET**

-20 V, -2.1 A, μCool™ Dual P-Channel, ESD, 1.6x1.6x0.55 mm UDFN Package

#### **Features**

- UDFN Package with Exposed Drain Pads for Excellent Thermal Conduction
- Low Profile UDFN 1.6x1.6x0.55 mm for Board Space Saving
- ESD Protected
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- High Side Load Switch
- PA Switch
- Optimized for Power Management Applications for Portable Products, such as Cell Phones, PMP, DSC, GPS, and others

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter		Symbol	Value	Units	
Drain-to-Source Voltage		V <sub>DSS</sub>	-20	V	
Gate-to-Source Vol	tage		V <sub>GS</sub>	±8.0	V
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-1.7	Α
Current (Note 1)	State	T <sub>A</sub> = 85°C		-1.2	
	t ≤ 5 s	T <sub>A</sub> = 25°C		-2.1	
Power Dissipa- tion (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	0.8	W
	t ≤ 5 s	T <sub>A</sub> = 25°C		1.3	
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-1.3	Α
Current (Note 2)	State	T <sub>A</sub> = 85°C		-0.9	
Power Dissipation (	(Note 2)	T <sub>A</sub> = 25°C	P <sub>D</sub>	0.5	W
Pulsed Drain Curre	nt	tp = 10 μs	I <sub>DM</sub>	-8.0	Α
Operating Junction Temperature	and Storage	e	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C
Source Current (Bo	dy Diode) (I	Note 2)	Is	-0.6	Α
Lead Temperature (1/8" from case for		g Purposes	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

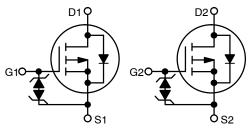
- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz. Cu.



#### ON Semiconductor®

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		MOSFET	
	$V_{(BR)DSS}$	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
Γ		200 mΩ @ -4.5 V	
	-20 V	290 mΩ @ -2.5 V	-2.1 A
	20 1	390 mΩ @ –1.8 V	2.17
		650 mΩ @ -1.5 V	



P-Channel MOSFET

#### MARKING DIAGRAM



UDFN6 CASE 517AT μCOOL™



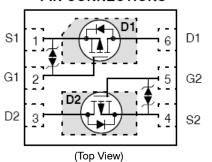
AD = Specific Device Code

M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

#### PIN CONNECTIONS



#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	155	°C/W
Junction-to-Ambient $-t \le 5 s$ (Note 3)	$R_{\theta JA}$	100	
Junction-to-Ambient - Steady State min Pad (Note 4)	$R_{\theta JA}$	245	

ELECTRICAL CHARACTERISTICS	$S (T_J = 25^{\circ}C \text{ unles})$	s otherwise specifie	ed)				
Parameter	Symbol	Test Co	ondition	Min	Тур	Max	Units
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I	<sub>D</sub> = -250 μA	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = -250 μA	A, ref to 25°C		-10		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -20 V	$T_{J} = 25^{\circ}C$ $T_{J} = 125^{\circ}C$			-1.0 -10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>		$V_{GS} = \pm 8.0 \text{ V}$			±10	μΑ
ON CHARACTERISTICS (Note 5)	.035	103 0 1,	- GS _====	ı			po t
Gate Threshold Voltage	V <sub>GS(TH)</sub>	Voe = Vne.	I <sub>D</sub> = -250 μA	-0.4		-1.0	V
Negative Threshold Temp. Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	•GS = •DS;	-10 = 200 ματ		2.8	1.0	mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5	V, I <sub>D</sub> = -2.0 A		160	200	mΩ
	D3(0H)		V, I <sub>D</sub> = -1.2 A		226	290	1
			/, I <sub>D</sub> = -0.24 A		300	390	
			/, I <sub>D</sub> = -0.18 A		390	650	
Forward Transconductance	9FS		V, I <sub>D</sub> = -1.5 A		3.7		S
CHARGES, CAPACITANCES & GATE	_	103	.,.,	<u> </u>			
Input Capacitance	C <sub>ISS</sub>				300		pF
Output Capacitance	C <sub>OSS</sub>		, f = 1 MHz,		34		1
Reverse Transfer Capacitance	C <sub>RSS</sub>	V <sub>DS</sub> =	= –10 V		29		
Total Gate Charge	Q <sub>G(TOT)</sub>				4.2		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>		10.1/		0.3		
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = -4.5 V_{ID} = -4.5 V_{ID}$	, V <sub>DS</sub> = -10 V; -1.7 A		0.7		
Gate-to-Drain Charge	Q <sub>GD</sub>				1.1		
SWITCHING CHARACTERISTICS, VG		l		<u>I</u>	l		
Turn-On Delay Time	t <sub>d(ON)</sub>	1		1	17.4		ns
Rise Time	t <sub>r</sub>		V 40.V		32.3		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = -4.5 \text{ V},$ $I_{D} = -1.5 \text{ A}$	$V_{DD} = -10 \text{ V},$ $A, R_{G} = 1 \Omega$		149		
Fall Time	t <sub>f</sub>				74		
DRAIN-SOURCE DIODE CHARACTER	•	1		<u> </u>			
Forward Diode Voltage	VSD		T <sub>J</sub> = 25°C		0.8	1.2	V
Ŭ		$V_{GS} = 0 \text{ V},$ $I_{S} = -0.6 \text{ A}$	T <sub>J</sub> = 125°C		0.68		1
Reverse Recovery Time	t <sub>RR</sub>		<u> </u>		10.6		ns
Charge Time	t <sub>a</sub>	\/ 0\/ dia	/dt = 100 A/μs,		8.7		
Discharge Time	t <sub>b</sub>		/dt = 100 A/μs, -1.0 A		1.9		
Reverse Recovery Charge	Q <sub>RR</sub>	1			5.1		nC

- 3. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces). 4. Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz. Cu. 5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

- 6. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

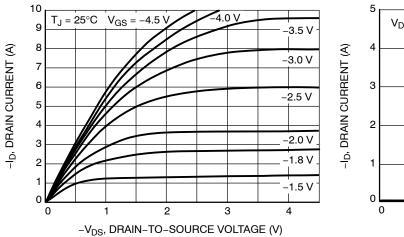
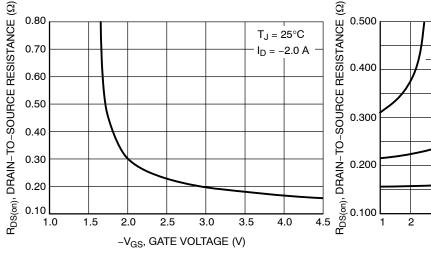


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



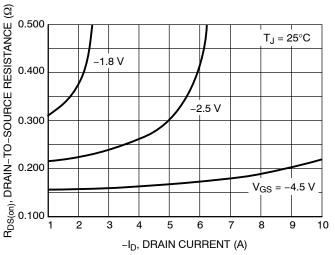
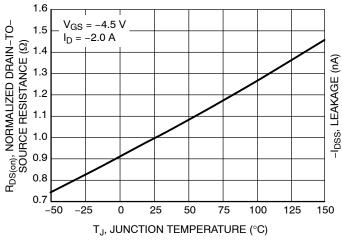


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



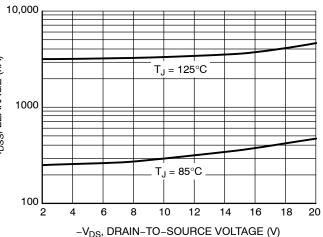
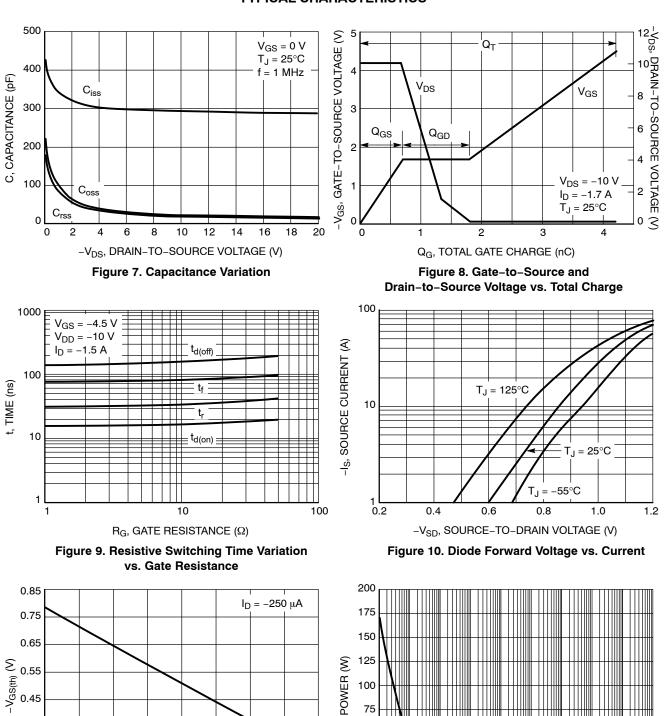


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**



T<sub>J</sub>, JUNCTION TEMPERATURE (°C)
Figure 11. Threshold Voltage

50

75

100

125

150

0.35

0.25

0.15

-50

-25

0

25

SINGLE PULSE TIME (s)

Figure 12. Single Pulse Maximum Power
Dissipation

1.E-01

1.E+01

1.E+03

1.E-03

50

25

1.E-05

#### **TYPICAL CHARACTERISTICS**

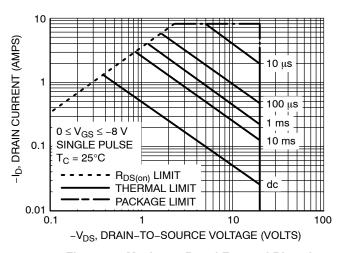


Figure 13. Maximum Rated Forward Biased Safe Operating Area

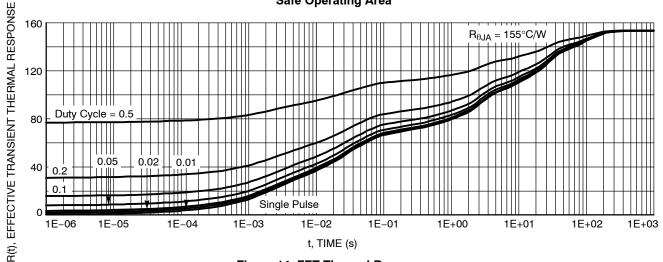


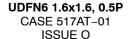
Figure 14. FET Thermal Response

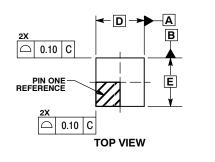
#### **DEVICE ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTLUD3A260PZTAG	UDFN6 (Pb-Free)	3000 / Tape & Reel
NTLUD3A260PZTBG	UDFN6 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS





**DETAIL B** 

SIDE VIEW

**BOTTOM VIEW** 

0.05 C

0.05 C

**DETAIL A** 

6X K

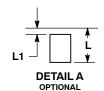
(A3)

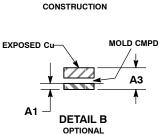
**E**1

0.10 C A B

0.05 | C | NOTE 3

C SEATING PLANE



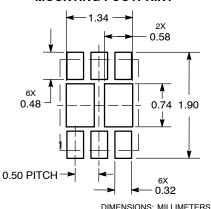


#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS. 3. DIMENSION 6 APPLIES TO PLATED TERMINAL
- DIMENSION b APPLIES TO PLATED TERMIN AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM TERMINAL.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS		
DIM	MIN	MAX	
Α	0.45	0.55	
A1	0.00	0.05	
АЗ	0.13	REF	
b	0.20	0.30	
D	1.60 BSC		
Е	1.60 BSC		
е	0.50 BSC		
D1	1.14	1.34	
D2	0.38	0.58	
E1	0.54	0.74	
Κ	0.20		
Ĺ	0.15	0.35	
L1		0.10	

## SOLDERMASK DEFINED MOUNTING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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